RoHS

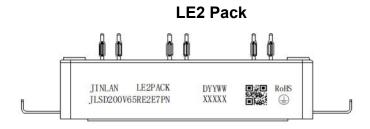


# JLSD200V65RE2E7PN

## Stack Boost Module with 650V Trench Stop IGBTs

#### **Features**

- Electrical features
  - 650V Trench Stop IGBTs
  - Low Inductive Design
  - Low Switching Losses
  - Low Inductive Layout
  - Thermistor
- · Mechanical features
  - Compact Design
  - Pressfit contact technology
  - Al<sub>2</sub>O<sub>3</sub> Substrate with Low Thermal Resistance



#### **Typical Applications**

Welding

JINLAN = Company Name

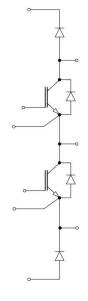
JLSD200V65RE2E7PN = Specific Device Code

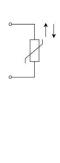
YYWW = Year and Work Week Code

XXXXX = Serial Number

QR code = Custom Assembly Information

#### **Description**





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## Package Insulation coordination

Parameter	Symbol	Note or test condition	Values	Unit
Isolation test voltage	Visol	RMS,f=50Hz,t=60s	2.5	kV
Internal isolation		basic insulation(class 1,IEC 61140)	Al <sub>2</sub> O <sub>3</sub>	
Creepage distance	d <sub>creep</sub>	terminal to heatsink	11.5	mm
Clearance	d <sub>clear</sub>	terminal to heatsink	10	mm
Comparative tracking index (electrical)	СТІ		>200	
RTI Elec.	RTI	housing	140	$^{\circ}$

## **Package Characteristic values**

Parameter		Note or test condition    Values				
	Symbol		Min.	Тур.	Max.	Unit
Stray Inductance	LCE			20		nH
Module Lead Resistance, Terminal to Chip	Rcc'+EE'			2		mΩ
Storage Temperature Range	Т <sub>втб</sub>		-40		125	$^{\circ}$ C
Mountig force per clamp	F		40		80	N
Weight	G			39		g



### **IGBT**

#### Absolute Maximum Ratings (Tc = 25°C unless otherwise noted)

Symbol	Description	Value	Unit
V <sub>CES</sub>	Collector-Emitter Voltage	650	V
V <sub>GES</sub>	Gate-Emitter Voltage	±30	V
I <sub>CDC</sub>	Continuous Collector Current @ Tc = 80°C (TJMAX = 175°C)	200	Α
I <sub>CM</sub>	Pulsed Collector Current, $t_p$ limited by $T_{v_j max}$	400	Α
Tjmax	Maximum Junction Temperature	175	$^{\circ}$
PD	Power Dissipation @ T <sub>C</sub> = 25°C	456	W
	Power Dissipation @T <sub>C</sub> = 100 °C	227	W

#### **Characteristics** (Tc=25<sup>o</sup>C unless otherwise noted)

Symbol	Parameter	Test Condition		Min	Тур	Max	Unit
		I <sub>C</sub> =100A,	T <sub>vj</sub> = 25 °C	-	1.15	1.90	
.,	Collector Emitter Seturation Voltage	V <sub>GE</sub> = 15V	T <sub>vj</sub> = 175 °C		1.25		V
V <sub>CE(sat)</sub>	Collector-Emitter Saturation Voltage	I <sub>C</sub> =200A,	T <sub>vj</sub> = 25 °C		1.45	2.20	V
	V <sub>GE</sub> = 15V T <sub>vi</sub> = 175 °C		1.75				
V <sub>GE(TH)</sub>	Gate-Emitter Threshold Voltage	I <sub>C</sub> =3mA	,V <sub>CE</sub> =V <sub>GE</sub>	4.0		5.5	V
I <sub>CES</sub>	Collector-Emitter Cutoff Current	V <sub>GE</sub> = 0 V,	V <sub>CE</sub> = 650 V			200	μΑ
I <sub>GES</sub>	Gate-Emitter Leakage Current	$V_{GE}$ = $\pm 30$ V, $V_{C}$	<sub>E</sub> = 0 V, T <sub>vj</sub> = 25°C	-		±100	nA
RGint	Internal Gate Resistance	T <sub>vj</sub> =	25 °C	-	0.8		Ω
Cies	Input Capacitance	., .,			12080		pF
Coes	Output capacitance	1	V,V <sub>GE</sub> =0V, :1MHz		424		pF
Cres	Reverse Transfer	1-	· IIVIITZ		52		pF
$Q_{G}$	Gate Charge	T <sub>J</sub> = 1 V <sub>CE</sub> = 400 V V <sub>GE</sub> = -5 V			0.381		μC
td(on)	Turn-On Delay Time	$V_{CE}$ =400V, $I_{C}$ =200A, $V_{GE}$ = -5 V to +15 V, $R_{G}$ =5 $\Omega$ Inductive Load Tvi=25°C			124	-	
tr	Rise Time				99		ns
td(off)	Turn-off Delay Time				288		115
tf	Fall Time			-	55	1	
Eon	Turn-On Switching Loss per Pulse	I Vj=.	25 C		9.1		
Eoff	Turn Off Switching Loss per Pulse			-	5.3		mJ
td(on)	Turn-On Delay Time			1	TBD	1	
tr	Rise Time				TBD	-	no
td(off)	Turn−off Delay Time	V <sub>CE</sub> =400V			TBD		ns
tf	Fall Time	V <sub>GE</sub> = -5 V to +15 V, R <sub>G</sub> =5Ω T <sub>j</sub> =175°C			TBD		
Eon	Turn-on Switching Loss per Pulse				13.0	-	
Eoff	Turn Off Switching Loss per Pulse				7.0	-	mJ
RthJC	Thermal resistance	Junction-to-Ca	ase (per IGBT)		0.294		K/W
T <sub>vj op</sub>		Temperature under	switching conditions	-40		175 <sup>1)</sup>	$^{\circ}$

 $<sup>^{1)}</sup>T_{\nu j\,op}$  > 150  $^{\circ}{\rm C}$  is only allowed for operation at overload conditions.



## Diode

#### **Absolute Maximum Ratings** (Tc = 25°C unless otherwise noted)

Symbol	Description	Value	Unit
$V_{RRM}$	Repetitive Peak Reverse Voltage	650	V
I <sub>F</sub>	Diode Continuous Forward Current	200	Α
I <sub>FM</sub>	Diode Maximum Forward Current t <sub>p</sub> =1ms	400	Α

#### Characteristics (Tc=25℃ unless otherwise noted)

Symbol	Parameter	Test Condition	1	Min	Тур	Max	Unit
		T <sub>J</sub> = 25°C	<sub>J</sub> = 25°C		1.40	2.40	
.,	Diada Famuand Valtana	I <sub>F</sub> = 100 A	<sub>J</sub> = 175°C		1.30		V
VF	Diode Forward Voltage	1 -	<sub>J</sub> = 25°C		1.80	2.80	V
		I <sub>F</sub> = 200 A	<sub>J</sub> = 175°C		1.65		V
Trr	Reverse Recovery Time				265		ns
$I_{RM}$	Peak Reverse Recovery Current	$V_{CE}=400V$ , $V_{GE}=-5 V \text{ to } +15$	5 V,		58		Α
Qrr	Recovered Charge	I <sub>F</sub> =200A,R <sub>G</sub> =59 T <sub>Vi</sub> =25°C	Ω,		7.69		μC
Erec	Reverse Recovery Energy	1 1 V 1 - 2 3 G			0.83		mJ
Trr	Reverse Recovery Time	V <sub>CE</sub> =400V,			357		ns
$I_{RM}$	Peak Reverse Recovery Current	$V_{GE} = -5 \text{ V to } +18$	5 V		83		Α
Qrr	Recovered Charge	I <sub>F</sub> =200A,R <sub>G</sub> =5Ω T <sub>vi</sub> =175°C	Ω,		14.64		μC
E <sub>rec</sub>	Reverse Recovery Energy	- 1 <sub>VJ</sub> =173 C			1.06		mJ
$R_{\text{thJC}}$	Thermal resistance	Junction-to-Case (pe	r diode)		0.32		K/W
$T_{vjop}$		Temperature under switchi	ng conditions	-40		175 <sup>2)</sup>	$^{\circ}$

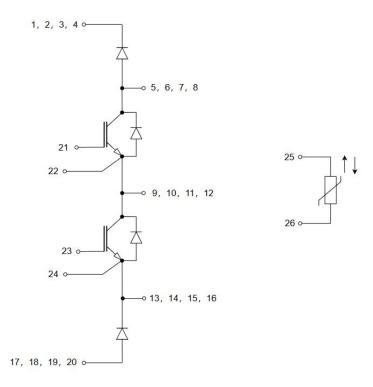
 $<sup>^{2)}</sup>T_{\nu j \, op}$  > 150  $^{\circ}$ C is only allowed for operation at overload conditions.

#### NTC Characteristics (Tc = 25°C unless otherwise noted)

Symbol	Parameter	Test Condition	Min	Тур	Max	Unit
R <sub>25</sub>	Rated Resistance			5.0		kΩ
ΔR/R	Deviation of R100	Tc=100 ℃,R100=493.3Ω	-5		5	%
P <sub>25</sub>	Power Dissipation				20.0	mW
B <sub>25/50</sub>	B-value	R <sub>2</sub> =R <sub>25</sub> exp[B <sub>25/50</sub> (1/T <sub>2</sub> - 1/(298.15K))]		3375		К
B <sub>25/80</sub>	B-value	R <sub>2</sub> =R <sub>25</sub> exp[B <sub>25/80</sub> (1/T <sub>2</sub> - 1/(298.15K))]		3411		К
B <sub>25/100</sub>	B-value	R <sub>2</sub> =R <sub>25</sub> exp[B <sub>25/100</sub> (1/T <sub>2</sub> - 1/(298.15K))]		3433		К

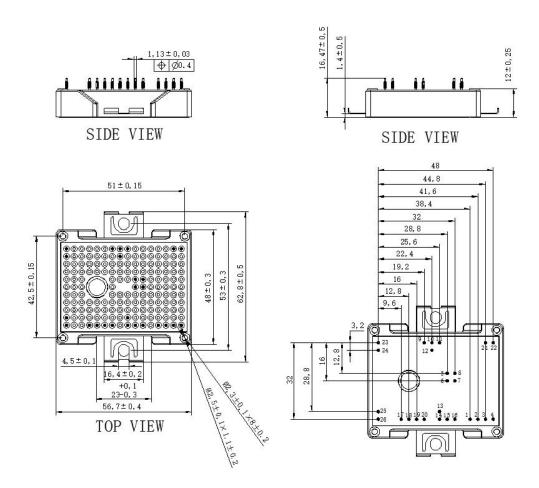


#### **CIRCUIT DIAGRAM**



#### **PACKAGE DIMENSION**

#### **Dimensions in Millimeters**





### **REVISION HISTORY**

Document version	Date of release	Description of changes
Rev.00	2025-01-07	Preview



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